

1.5V LOW-POWER WIDE-RANGE FREQUENCY CLOCK DRIVER
ICS98UAE877A

Description

The PLL clock buffer, ICS98UAE877A, is designed for a VDDQ of 1.5V, an AVDD of 1.5V and differential data input and output levels.

ICS98UAE877A is a zero delay buffer that distributes a differential clock input pair (CLK_INT, CLK_INC) to ten differential pair of clock outputs (CLKT[0:9], CLKC[0:9]) and one differential pair feedback clock outputs (FB_OUTT, FBOUTC). The clock outputs are controlled by the input clocks (CLK_INT, CLK_INC), the feedback clocks (FB_INT, FB_INC), the LVCMOS program pins (OE, OS) and the Analog Power input (AVDD). When OE is low, the outputs (except FB_OUTT/FB_OUTC) are disabled while the internal PLL continues to maintain its locked-in frequency. OS (Output Select) is a program pin that must be tied to GND or VDDQ. When OS is high, OE will function as described above. When OS is low, OE has no effect on CLKT7/CLKC7 (they are free running in addition to FB_OUTT/FB_OUTC). When AVDD is grounded, the PLL is turned off and bypassed for test purposes.

When both clock signals (CLK_INT, CLK_INC) are logic low, the device will enter a low power mode. An input logic detection circuit on the differential inputs, independent from the input buffers, will detect the logic low level and perform a low power state where all outputs, the feedback and the PLL are OFF. When the inputs transition from both being logic low to being differential signals, the PLL will be turned back on, the inputs and outputs will be enabled and the PLL

will obtain phase lock between the feedback clock pair (FB_INT, FB_INC) and the input clock pair (CLK_INT, CLK_INC) within the specified stabilization time tSTAB.

The PLL in ICS98UAE877A clock driver uses the input clocks (CLK_INT, CLK_INC) and the feedback clocks (FB_INT, FB_INC) to provide high-performance, low-skew, low-jitter output differential clocks (CLKT[0:9], CLKC[0:9]). ICS98UAE877A is also able to track Spread Spectrum Clocking (SSC) for reduced EMI.

ICS98UAE877A is available in Commercial Temperature Range (0°C to 70°C) and Industrial Temperature Range (-40°C to +85°C). See Ordering Information for details

Features

- Low skew, low jitter PLL clock driver
- 1 to 10 differential clock distribution
- Feedback pins for input to output synchronization
- Spread Spectrum tolerant inputs
- Auto PD when input signal is at a certain logic state
- Available in 52-ball VFBGA and a 40-pin MLF

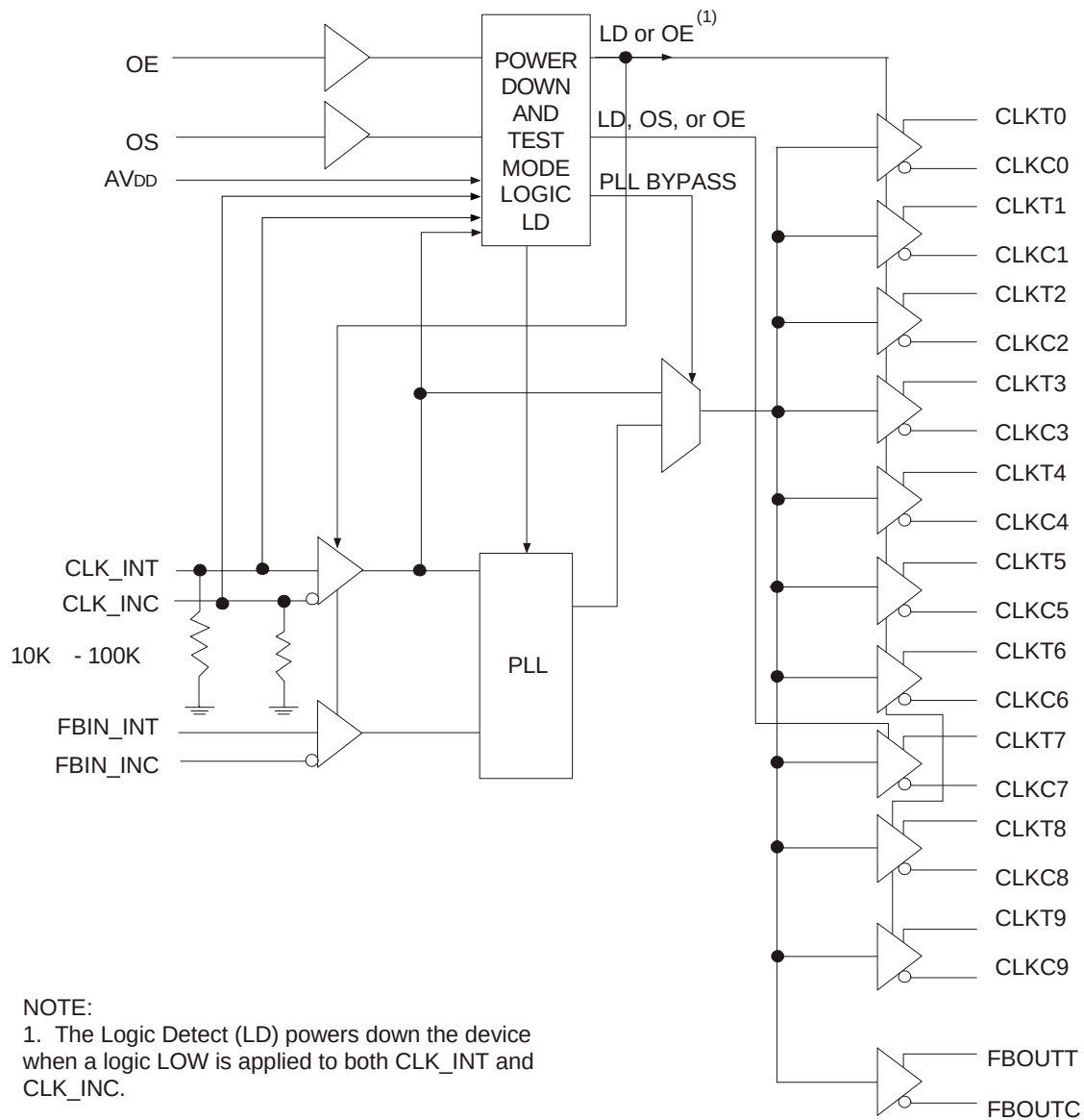
Applications

- DDR2 Memory Modules / Zero Delay Board Fan Out
- Provides complete DDR DIMM solution with IDT74SSTUAE32xxx family

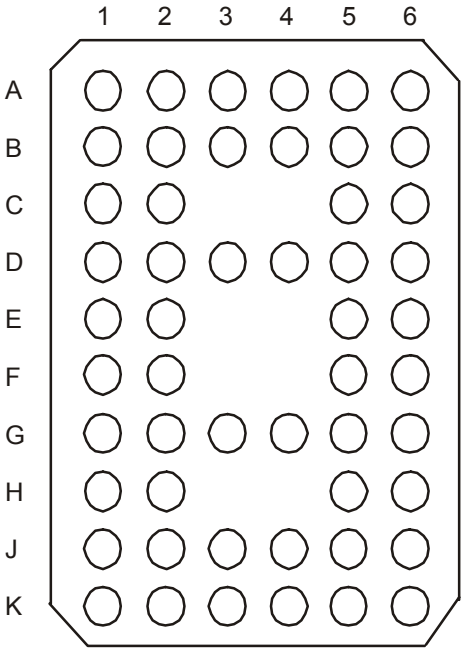
Switching Characteristics

- Period jitter: 40ps (DDR2-400/533)
30ps (DDR2-667)
- Half-period jitter: 60ps (DDR2-400/533)
50ps (DDR2-667)
- Output-Output Skew 40ps (DDR2-400/533)
30ps (DDR2-667)
- Cycle-Cycle Jitter 40ps

Block Diagram

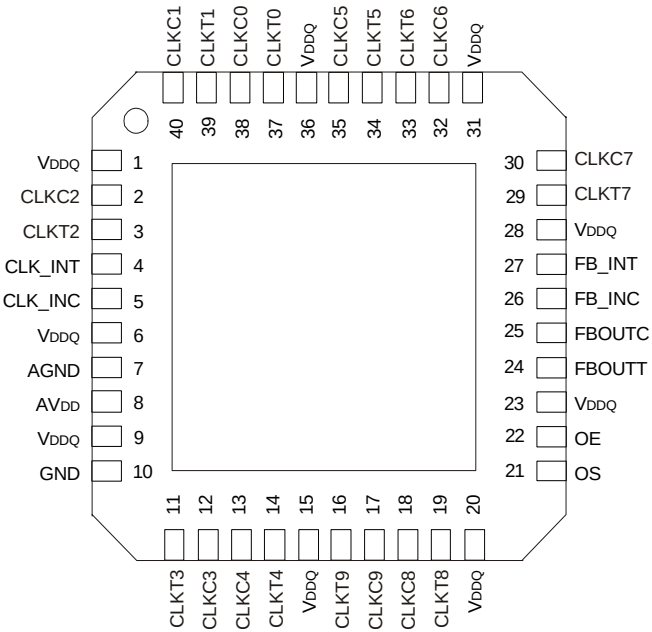


Pin Configurations



	1	2	3	4	5	6
A	CLKT1	CLKT0	CLKC0	CLKC5	CLKT5	CLKT6
B	CLKC1	GND	GND	GND	GND	CLKC6
C	CLKC2	GND	NB	NB	GND	CLKC7
D	CLKT2	VDDQ	VDDQ	VDDQ	OS	CLKT7
E	CLK_INT	VDDQ	NB	NB	VDDQ	FB_INT
F	CLK_INC	VDDQ	NB	NB	OE	FB_INC
G	AGND	VDDQ	VDDQ	VDDQ	VDDQ	FB_OUTC
H	AVDD	GND	NB	NB	GND	FB_OUTT
J	CLKT3	GND	GND	GND	GND	CLKT8
K	CLKC3	CLKC4	CLKT4	CLKT9	CLKC9	CLKC8

**176 BALL BGA
TOP VIEW**



**40-PIN MLF
TOP VIEW**

Pin Descriptions

Terminal Name	Description	Electrical Characteristics
AGND	Analog Ground	Ground
AVDD	Analog Power	1.5V Nominal
CLK_INT	Clock Input with a 10K-100K Ω pulldown resistor	Differential Input
CLK_INC	Complementary Clock Input with a 10K-100K Ω pulldown resistor	Differential Input
FB_INT	Feedback Clock Input	Differential Input
FB_INC	Complementary Feedback clock input	Differential Input
FB_OUTT	Feedback Clock Output	Differential Output
FB_OUTC	Complementary Feedback clock Output	Differential Output
OE	Output Enable (Asynchronous)	LVC MOS Input
OS	Output Select (tied to GND or VDDQ)	LVC MOS Input
GND	Ground	Ground
VDDQ	Logic and Output Power	1.5V Nominal
CLKT[0:9]	Clock Outputs	Differential Outputs
CLKC[0:9]	Complementary Clock Outputs	Differential Outputs
NB	No Ball	

Function Table

Inputs					Outputs				PLL
AV _{DD}	OE	OS	CLK_ INT	CLK_ INC	CLKT	CLKC	FB_ OUTT	FB_ OUTC	
GND	H	X	L	H	L	H	L	H	Bypassed/Off
GND	H	X	H	L	H	L	H	L	Bypassed/Off
GND	L	H	L	H	L(Z) ¹	L(Z) ¹			Bypassed/Off
GND	L	L	H	L	L(Z), CLKT7 active ¹	L(Z), CLKC7 active ¹	H	L	Bypassed/Off
1.5V (nom)	L	H	L	H	L(Z) ¹	L(Z) ¹	L	H	On
1.5V (nom)	L	L	H	L	L(Z), CLKT7 active ¹	L(Z), CLKC7 active ¹	H	L	On
1.5V (nom)	H	X	L	H	L	H	L	H	On
1.5V (nom)	H	X	H	L	H	L	H	L	On
1.5V (nom)	X	X	L	L	L(Z) ¹	L(Z) ¹	L(Z) ¹	L(Z) ¹	Off
1.5V (nom)	X	X	H	H	Reserved				

¹ Outputs are disabled to a LOW state meeting the IODL limit.

Absolute Maximum Ratings

Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Item	Rating
Supply Voltage, (AV _{DD} and V _{DDQ})	-0.5V to 2.5V
Logic Inputs	GND - 0.5V to V _{DDQ} + 0.5V
Ambient Operating Temperature	-40° C to +85° C
Storage Temperature	-65 to +150° C

DC Electrical Characteristics Over Operating Range

Following Conditions Apply Unless Otherwise Specified:

Commercial: $T_A = 0^{\circ}\text{C}$ to $+70^{\circ}\text{C}$, Industrial: $T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$; Supply Voltage $AV_{DD}/V_{DDQ} = 1.5\text{V} \pm 0.075\text{V}$.

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
VOH	Output HIGH Voltage	IOH = -100 μA	$V_{DDQ} - 2$			V
		IOH = -6mA	1.1	1.45		
VOL	Output LOW Voltage	IOL = 100 μA		0.25	0.1	V
		IOL = 6mA			0.6	
VIK	Input Clamp Voltage	IIN = -18mA			-1.2	V
IiH	Input HIGH Current	CLK_INT, CLK_INC; $V_I = V_{DD}$ or GND			± 250	μA
IiL	Input LOW Current	OS, FB_INT, FB_INC; $V_I = V_{DD}$ or GND			± 10	μA
IODL	Output Disabled LOW Current	OE = L, $V_{ODL} = 100\text{mV}$	100			μA
IDD1.5	Operating Supply Current	CL = 0pF @ 410MHz			300	mA
IDDLD		CL = 0pF			500	μA
CIN ¹	Input Capacitance	$V_I = V_{DDQ}$ or GND	2		3	pF
COU ¹	Output Capacitance	$V_{OUT} = V_{DDQ}$ or GND	2		3	

1 Guaranteed by design, not 100% tested in production.

Recommended Operating Conditions

Following Conditions Apply Unless Otherwise Specified:

Commercial: $T_A = 0^{\circ}\text{C}$ to $+70^{\circ}\text{C}$, Industrial: $T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$; Supply Voltage $AV_{DD}/V_{DDQ} = 1.5\text{V} \pm 0.075\text{V}$.

Symbol	Parameter ¹	Conditions	Min.	Typ.	Max.	Units
AV_{DD}, V_{DDQ}	Supply Voltage		1.425	1.5	1.575	V
V_{IL}	LOW - Level Input Voltage	CLK_INT, CLK_INC, FB_INT, FB_INC OE, OS			$0.35 \times V_{DDQ}$	V
V_{IH}	HIGH -Level Input Voltage	CLK_INT, CLK_INC, FB_INT, FB_INC OE, OS	$0.65 \times V_{DDQ}$			V
V_{IN}	DC Input Signal Voltage ²		-0.3		$V_{DDQ} + 0.3$	V
V_{ID}	Differential Input Signal Voltage ³	DC - CLK_INT, CLK_INC, FB_INT, FB_INC AC - CLK_INT, CLK_INC, FB_INT, FB_INC	0.35 0.6		$V_{DDQ} + 0.4$	V
V_{OX}	Output Differential Cross-Voltage ⁴		$V_{DDQ}/2 - 0.1$		$V_{DDQ}/2 + 0.1$	V
V_{IX}	Input Differential Cross-Voltage ⁴		$V_{DDQ}/2 - 0.15$	$V_{DDQ}/2$	$V_{DDQ}/2 + 0.15$	
I_{OH}	HIGH-Level Output Current				-6	mA
I_{OL}	LOW-Level Output Current				6	
T_A	Operating Free-Air Temperature		-40		+85	$^{\circ}\text{C}$

1 Unused inputs must be held HIGH or LOW to prevent them from floating.

2 DC input signal voltage specifies the allowable DC execution of differential input.

3 Differential inputs signal voltages specifies the differential voltage [VTR-VCP] required for switching, where VTR is the true input level and VCP is the complementary input level.

4 Differential cross-point voltage is expected to track variations of V_{DDQ} and is the voltage at which the differential signal must be crossing.

Timing Requirements Over Recommended Operating Free-Air Temperature Range

Following Conditions Apply Unless Otherwise Specified:

Commercial: $T_A = 0^{\circ}\text{C}$ to $+70^{\circ}\text{C}$, Industrial: $T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$; Supply Voltage $AV_{DD}/V_{DDQ} = 1.5\text{V} \pm 0.075\text{V}$.

Symbol	Parameter ¹	Conditions	Min.	Max.	Units
freqOP	Max Clock Frequency ²	$1.5\text{V} \pm 0.075\text{V}$ @ 25°C	95	410	MHz
freqAPP	Application Frequency Range ³	$1.5\text{V} \pm 0.075\text{V}$ @ 25°C	160	410	MHz
dtIN	Input Clock Duty Cycle		40	60	%
TSTAB	CLK Stabilization ⁴			9	μs

1 The PLL must be able to handle spread spectrum induced skew.

2 Operating clock frequency indicates a range over which the PLL must be able to lock, but in which it is not required to meet the other timing parameters. (Used for low speed system debug.)

3 Application clock frequency indicates a range over which the PLL must meet all timing parameters.

4 Stabilization time is the time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal, within the value specified by the Static Phase Offset (t_{ϕ}), after power-up. During normal operation, the stabilization time is also the time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal when CLK and $\overline{\text{CLK}}$ go to a logic low state, enter the power-down mode and later return to active operation. CLK and $\overline{\text{CLK}}$ may be left floating after they have been driven low for one complete clock cycle.

Switching Characteristics Over Recommended Free Air Operating Range

Following Conditions Apply Unless Otherwise Specified:

Commercial: $T_A = 0^{\circ}\text{C}$ to $+70^{\circ}\text{C}$, Industrial: $T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$; Supply Voltage $AV_{DD}/V_{DDQ} = 1.5\text{V} \pm 0.075\text{V}$

Symbol	Parameter ¹	Conditions	(MHz)	Min.	Typ.	Max.	Units
t _{EN}	Output Enable Time	OE to any output	160 - 410		4.73	8	ns
t _{DIS}	Output Disable Time	OE to any output			5.82	8	ns
t _{JIT(PER)}	Period Jitter		160 - 270	-40		40	ps
			271 - 410	-30		30	
t _{JIT(HPER)}	Half-Period Jitter		160 - 270	-60		60	ps
			271 - 410	-50		50	
SLR1(i)	Input Slew Rate	Input Clock	160 - 410	1	2.5	4	v/ns
		Output Enable (OE, OS)		0.5			
SLR1(o)	Output Clock Slew Rate			0.8		2	v/ns
t _{JIT(CC+)}	Cycle-to-Cycle Period Jitter			0		40	ps
t _{JIT(CC-)}				0		-40	
t _{(ϕ) DYN}	Dynamic Phase Offset		160 - 270	-50		50	ps
			271 - 410	-20		20	
t _{SPO} ²	Static Phase Offset		271 - 410	-60	0	60	ps
Σ _{su}	t _{JIT(PER)} + t _{(ϕ) DYN} + t _{SKEW(O)}					80	ps
Σ _(h)	t _{(ϕ) DYN} + t _{SKEW(O)}					60	ps
t _{SKEW}	Output-to-Output Skew		160 - 270			60	ps
			271 - 410			30	
	SSC Modulation Frequency			30		33	KHz
	SSC Clock Input Frequency Deviation			0		-0.5	%
	PLL Loop Bandwidth (-3dB from unity gain)			2			MHz

1 Guaranteed for application frequency range.

2 Static phase offset shifted by design.

Parameter Measurement Information

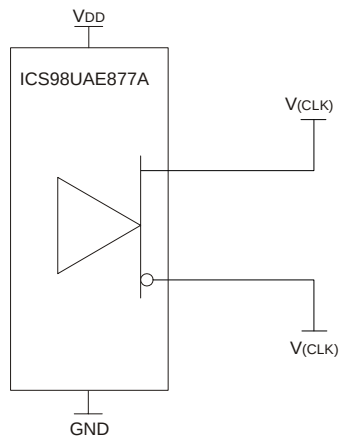


Figure 1: IBIS Model Output Load

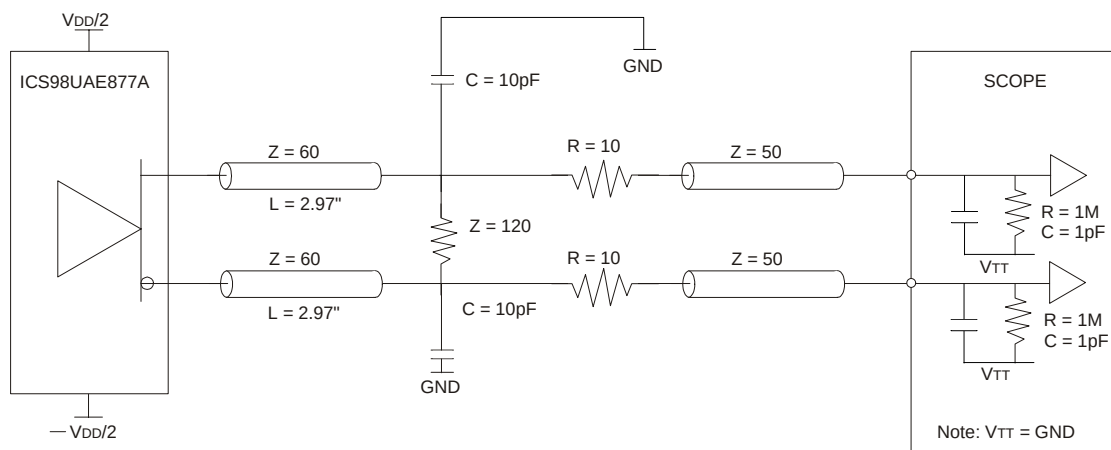


Figure 2: Output Load Test Circuit

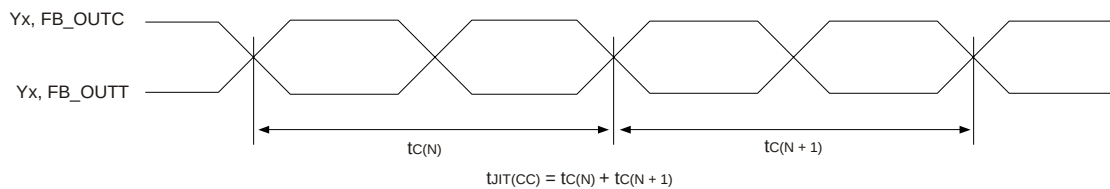


Figure 3: Cycle-to-Cycle Jitter

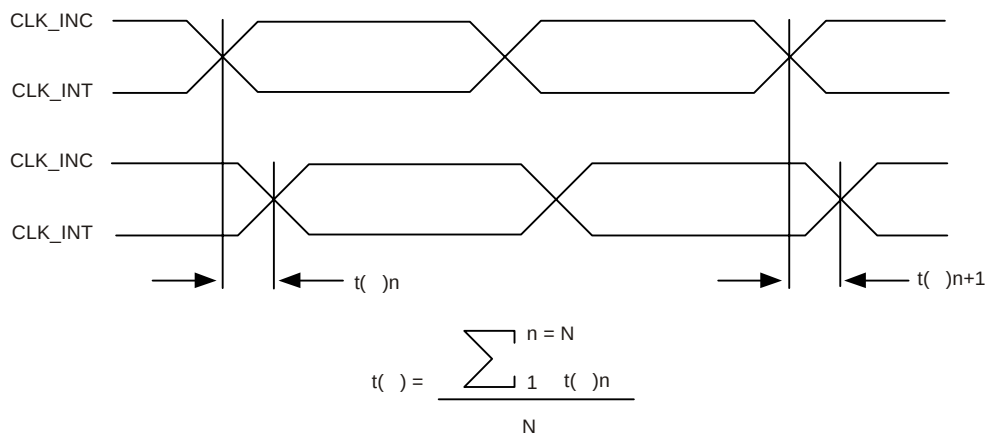


Figure 4: Static Phase Offset

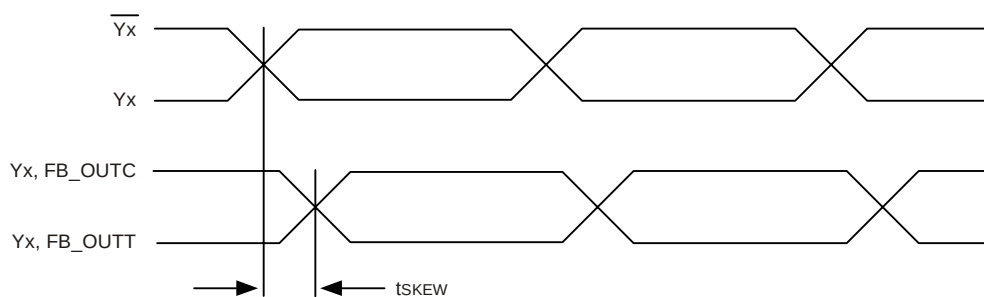
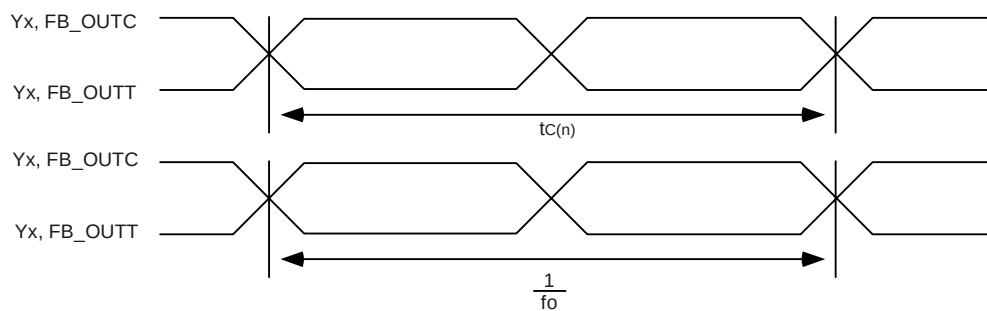
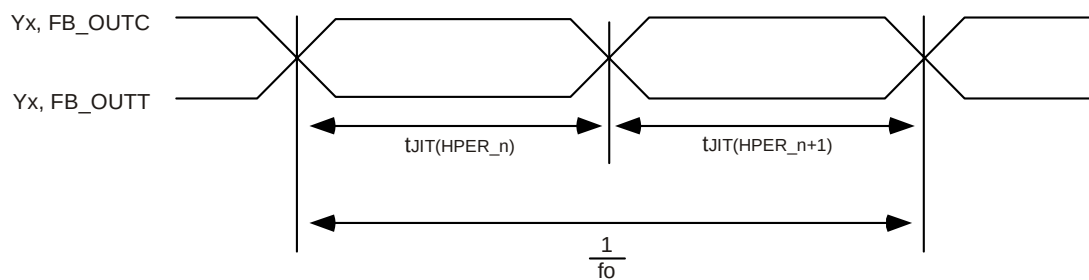


Figure 5: Output Skew



$$t_{(JIT_PER)} = t_{C(n)} - \frac{1}{f_0}$$

Figure 6: Period Jitter



$$t_{JIT}(HPER) = t_{JIT}(HPER_n) - \frac{1}{2xf_0}$$

Figure 7: Half-Period Jitter

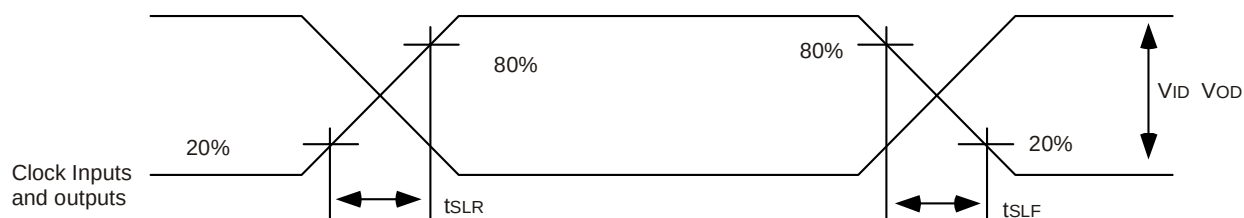


Figure 8: Input and Output Slew Rates

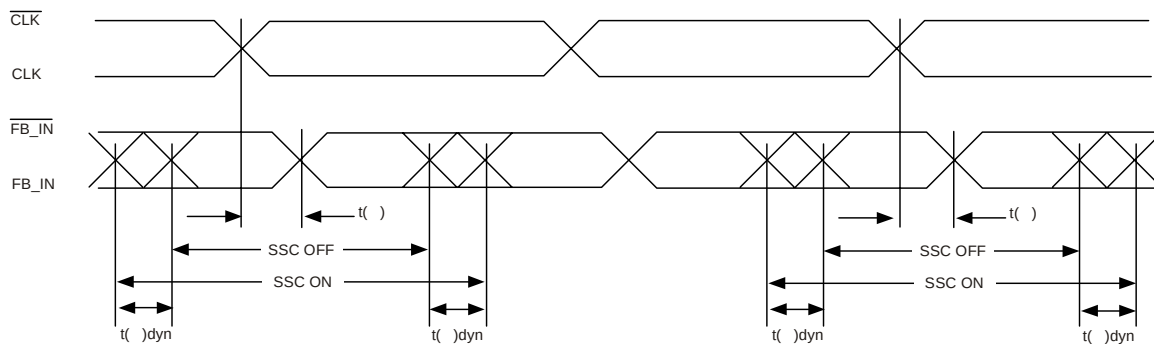
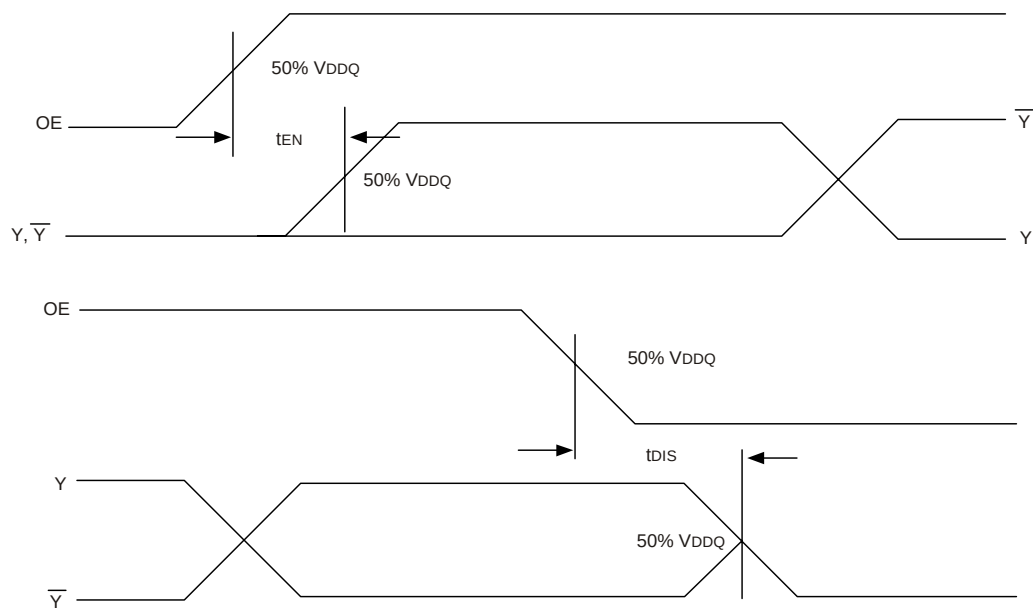


Figure 9: Dynamic Phase Offset

Figure 10: Time Delay Between OE and Clock Output (Y, $\overline{\text{Y}}$)

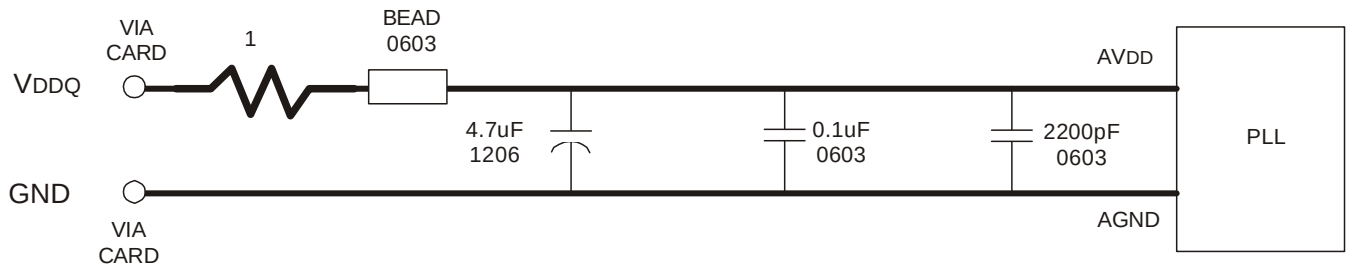


Figure 11. AVDD Filtering

*Place the 2200pF capacitors close to the PLL.

*Use wide traces for PLL Analog power and GND. Connect PLL and caps to AGND trace and connect trace to one GND via (farthest from PLL).

*Recommended bead: Fair-rite P/N 2506036017Y0 or equivalent (0.8 DC max., 600 at 100MHz).

Ordering Information

ICSS98UAE	XXX	XX	X	X		
	Device Type	Package	Shipping Carrier	Shipping Carrier		
					T	Tape and Reel
					Blank	0°C to +70°C (Commercial)
					I	-40°C to +85°C (Industrial)
					HLF	Low Profile, Fine Pitch, Ball Grid Array - Lead-Free
					KLF	Very Thin, Fine Pitch Quad Flat Package - Lead-Free
					877A	1.5V Low-Power Wide-Range Frequency Clock Driver

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